

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/535,696	TACHIBANA ET AL.	
Examiner	Art Unit	
Scott D. Long	1633	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
	T T	Subclass Date			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
PALM inventor search: Tachibana, Katsuro Nakashima, Misako	2/23/2007	SL		
EAST search: see attached sheets	2/23/2007	SL		
STN search: see attached sheets	2/23/2007	SL		
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